

<b>Notice of References Cited</b>	Application/Control No. 10/614,266	Applicant(s)/Patent Under Reexamination YAHALOMI ET AL.	
	Examiner Hector M Reyes	Art Unit 1625	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	CA 123:55430 for JP 07017899 , Tohishiro et al, (1995)
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